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U.S. Department of Commerce, Patent and Trademark Office	Docket No.: AM-1622-D1
Serial No.: 09/489,356	
Applicant: Shih et al.	
Filing Date: January 21, 2000	
Group: 1763	



LIST OF RELEVANT ART CITED BY APPLICANT

(Use several sheets if necessary)

U.S. PATENT DOCUMENTS

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
NP	AA	5,089,746	02/18/92	Rosenblum et al.	315	111.81	
	AB	5,268,200	12/07/93	Steger	427	249	
	AC	5,272,417	12/21/93	Ohmi	315	111.21	
	AD	5,429,870	07/04/95	Kmetz et al.	428	368	
	AE						
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	AG						
	AH						

FOREIGN PATENT DOCUMENTS (Translation)

		Document Number	Date	Country	Class	Subclass	Yes	No
NP	AL	09 087072	03/31/97	JP			abstract	
16	AM	58 034385	02/28/83	JP			abstract	
	AN							
	AO							
	AP							

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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

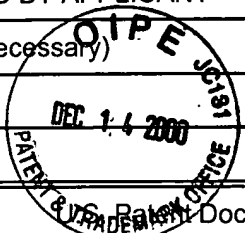
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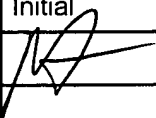
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					AM-1622.D1		09/489,356	
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(Use several sheets if necessary)					Hong Shih et al.			
					Filing Date		Group	
					21 Jan. 2000		1763	




U.S. Patent Documents							
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA	4,716,083	12/29/87	Eichen et al.	428	457	
	AB						
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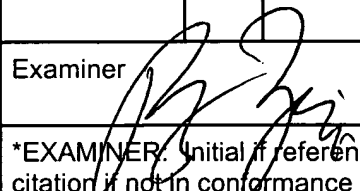
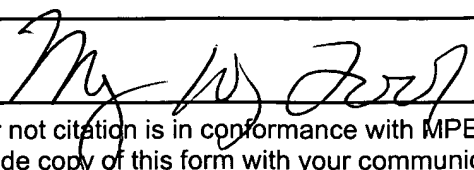
Foreign Patent Documents

Translation

		Document Number	Date	Country	Class	Subclass	Yes	No
	AH	1,317,617 /	5/23/73	UK				
	AJ	01-208446	8/22/89	JP			abstract	
	AK	0016252A1	10/1/80	EP				
	AL							
	AM							
	AN							

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	AO	Partial European Search Report
	AP	
	AQ	
	AR	

Examiner 	Date Considered 
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